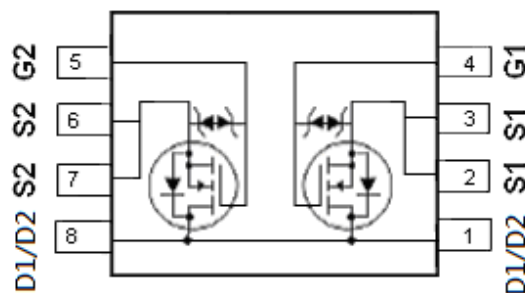


Dual N-Channel Enhancement Mode MOSFET

Features:

- 1.8V drive available
- Low on-resistance
- Fast switching speed
- Pb-free lead plating and halogen-free package



G : Gate S : Source D : Drain

BV_{DSS}	20V
$I_D@T_A=25^{\circ}C, V_{GS}=4.5V$	5A
$R_{DS(on)}@V_{GS}=4.5V, I_D=5A$	17.5m Ω (typ)
$R_{DS(on)}@V_{GS}=2.5V, I_D=2.6A$	25m Ω (typ)
$R_{DS(on)}@V_{GS}=1.8V, I_D=1A$	41m Ω (typ)

Ordering Information

Device	Package	Shipping
KWDN8810AT	TSSOP-8 (Pb-free lead plating and halogen-free package)	3000 pcs/ Tape & Reel

Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	20	V
Gate-Source Voltage	V _{GS}	±8	
Continuous Drain Current (Note 1)	I _D	T _A =25°C, V _{GS} =4.5V	5
		T _A =70°C, V _{GS} =4.5V	4
Pulsed Drain Current (Note 2)	I _{DM}	20	A
Total Power Dissipation (Note 1)	P _D	T _A =25°C	1
		T _A =70°C	0.64
Operating Junction and Storage Temperature Range	T _j ; T _{stg}	-55~+150	°C
Thermal Resistance, Junction-to-Ambient (Note 1)	R _{th,ja}	125	°C/W

Note : 1.Surface mounted on 1 in² copper pad of FR-4 board, t≤10sec. The value in any given application depends on the user's specific board design.

2.Pulse width ≤300μs, Duty Cycle≤2%

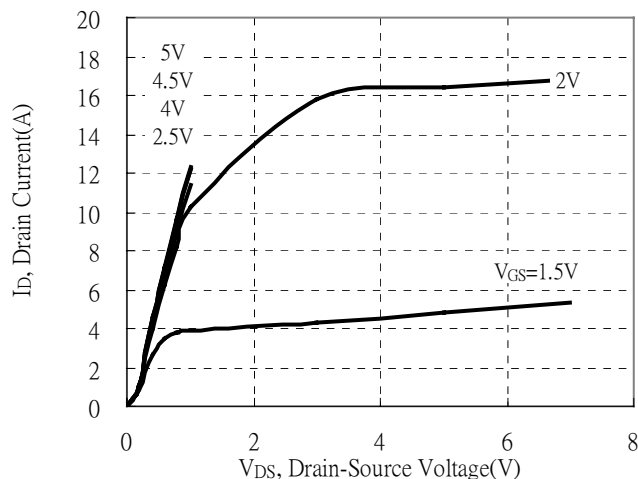
Electrical Characteristics (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	20	-	-	V	V _{GS} =0, I _D =250μA
V _{GS(th)}	0.4	0.75	1.0	V	V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±20	μA	V _{GS} =±8V, V _{DS} =0
I _{DSS}	-	-	1		V _{DS} =20V, V _{GS} =0
	-	-	25		V _{DS} =16V, V _{GS} =0, T _j =125°C
*R _{DS(ON)}	-	17.5	28	mΩ	I _D =5A, V _{GS} =4.5V
	-	25	40		I _D =2.6A, V _{GS} =2.5V
	-	41	60		I _D =1A, V _{GS} =1.8V
*G _{FS}	-	10	-	S	V _{DS} =5V, I _D =5A
Dynamic					
C _{iss}	-	509	-	pF	V _{DS} =10V, V _{GS} =0, f=1MHz
C _{oss}	-	100	-		
C _{rss}	-	81	-		
*t _{d(ON)}	-	5	-	ns	V _{DD} =10V, I _D =1A, V _{GS} =4.5V, R _G =6Ω
*t _r	-	11	-		
*t _{d(OFF)}	-	22	-		
*t _f	-	18	-		
*Q _g	-	7	-	nC	V _{DS} =10V, V _{GS} =4.5V, I _D =5A
*Q _{gs}	-	0.9	-		
*Q _{gd}	-	2.4	-		
Source Drain Diode					
*I _S	-	-	5	A	
*I _{SM}	-	-	20		
*V _{SD}	-	0.77	1.2	V	V _{GS} =0V, I _S =1.2A
*t _{rr}	-	14	-	ns	I _F =5A, dI _F /dt=100A/μs
*Q _{rr}	-	7	-	nC	

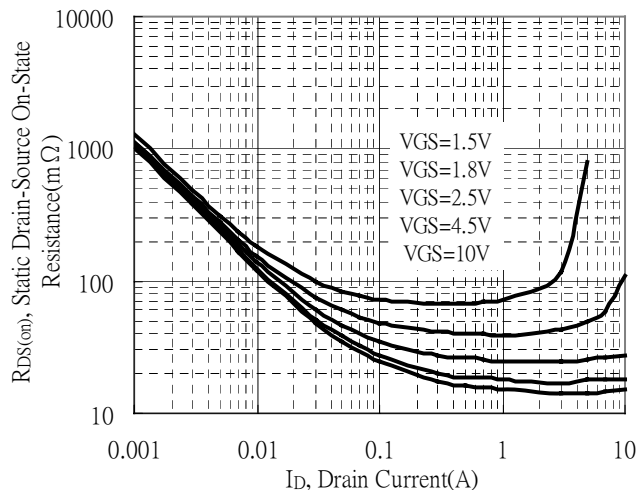
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Typical Characteristics

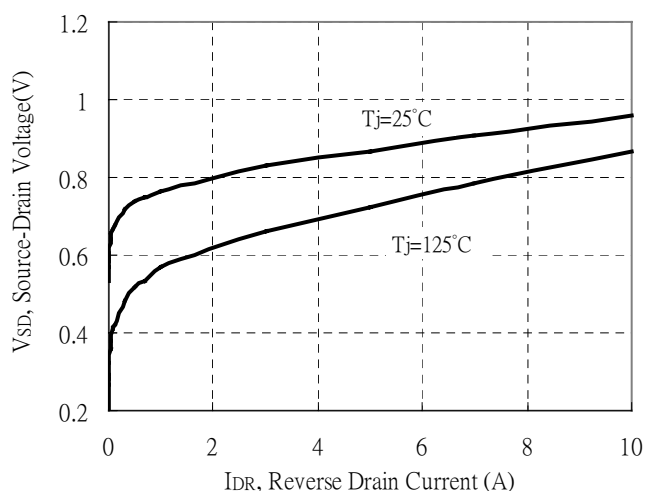
Typical Output Characteristics



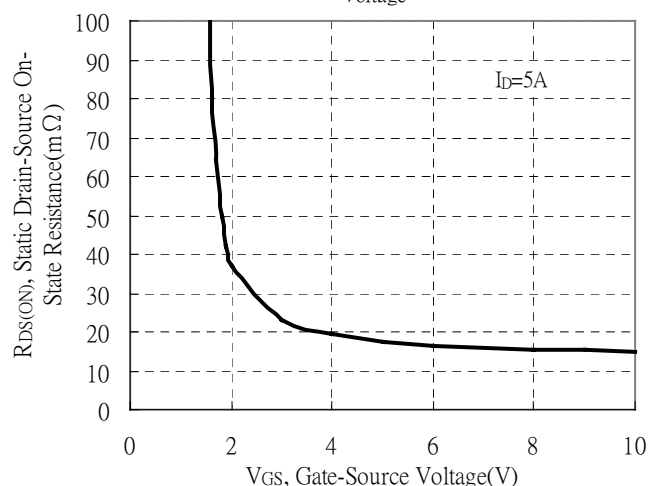
Static Drain-Source On-State resistance vs Drain Current



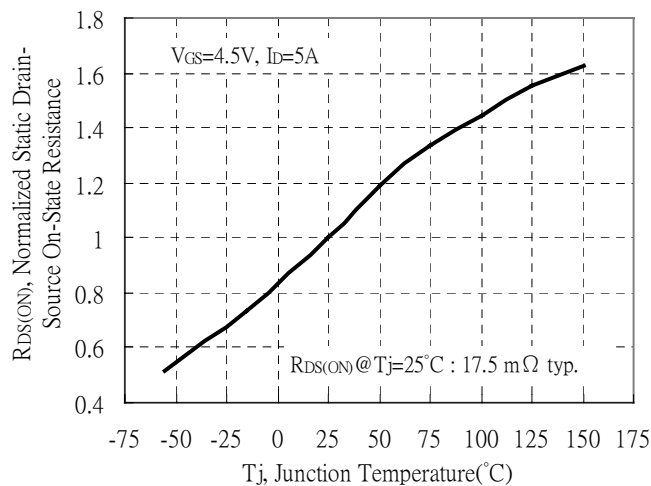
Reverse Drain Current vs Source-Drain Voltage



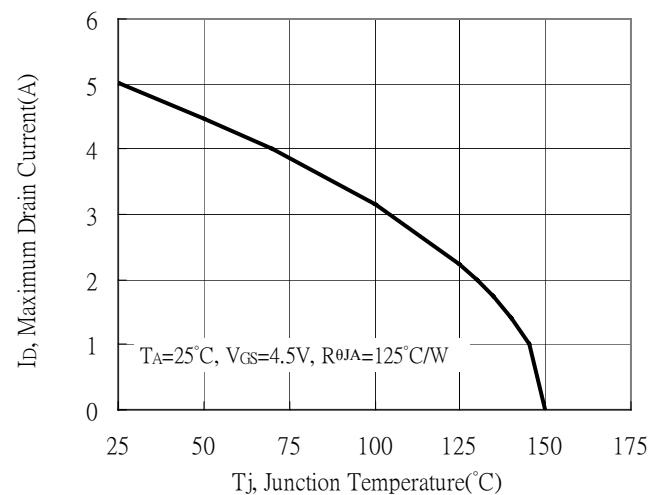
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

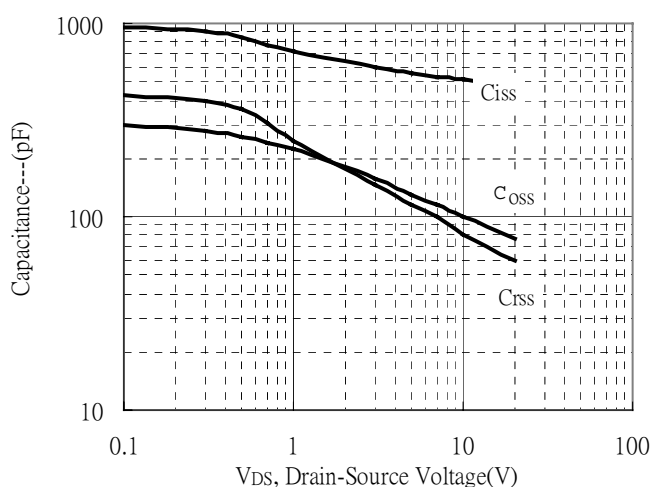


Maximum Drain Current vs Junction Temperature

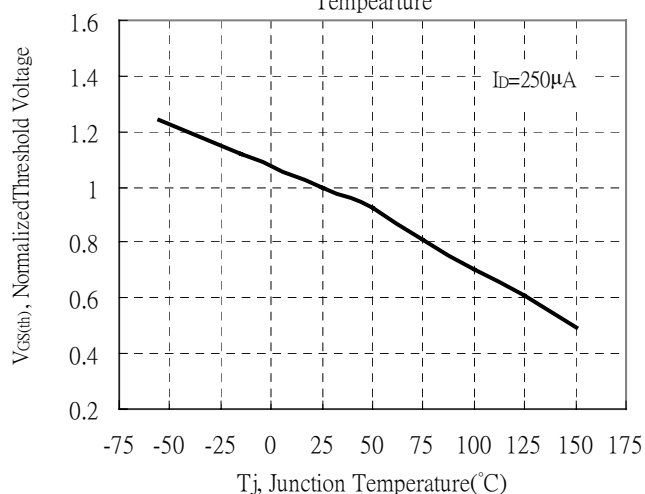


Typical Characteristics(Cont.)

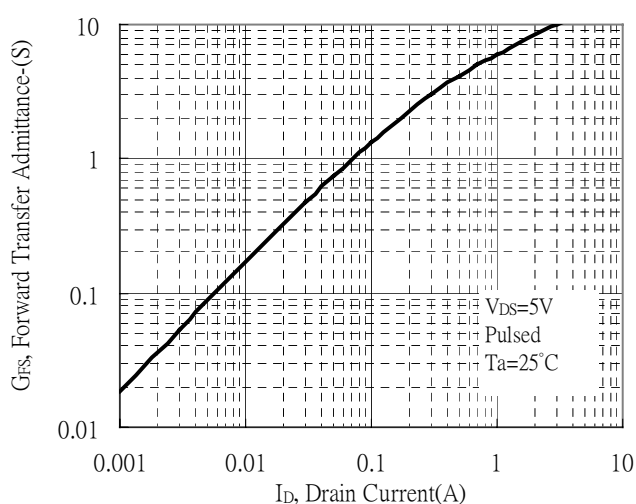
Capacitance vs Drain-to-Source Voltage



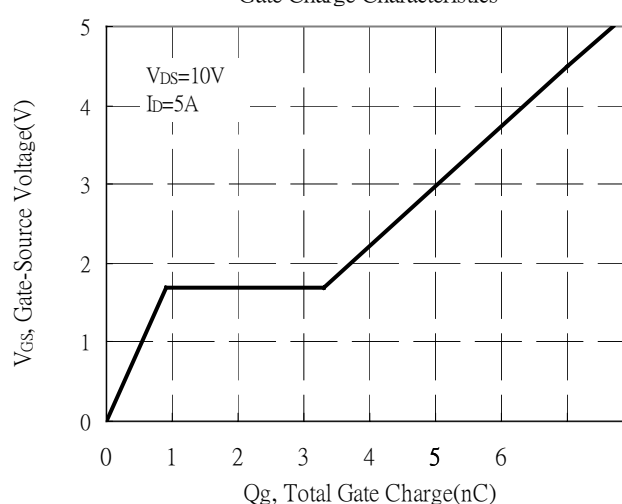
Normalized Threshold Voltage vs Junction Temperature



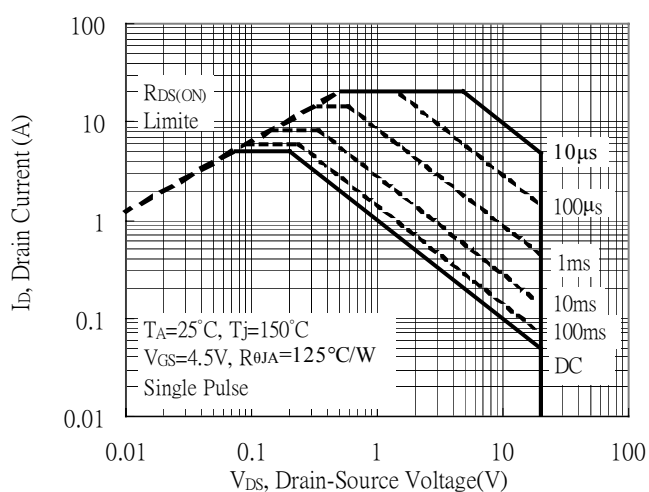
Forward Transfer Admittance vs Drain Current



Gate Charge Characteristics

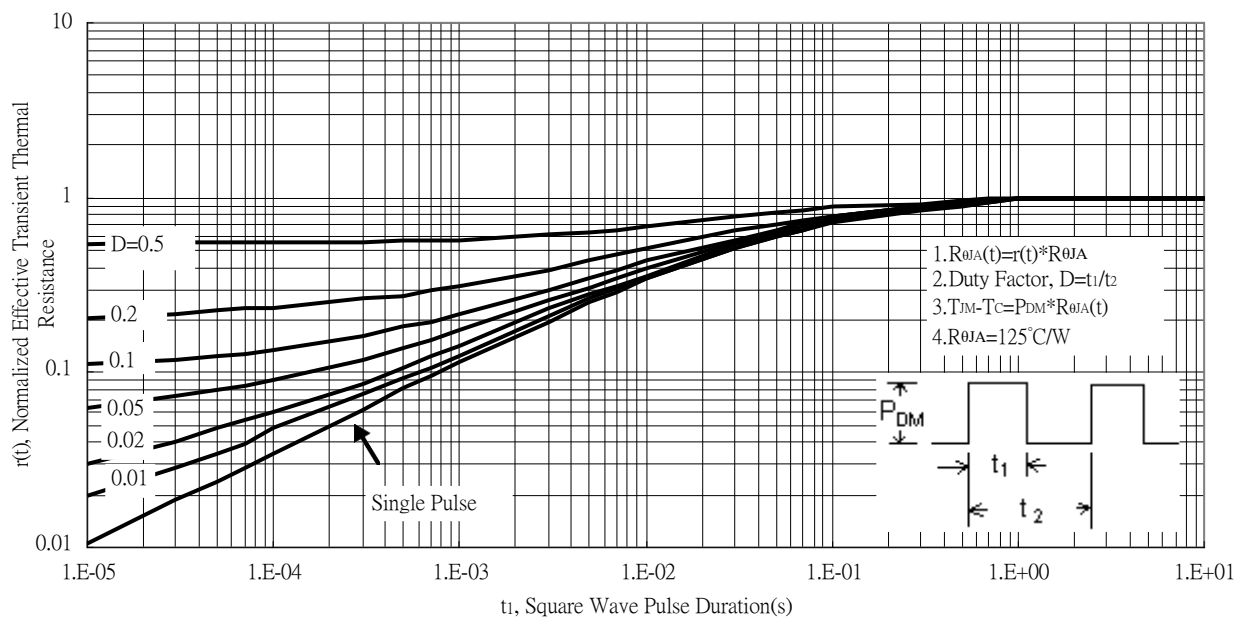


Maximum Safe Operating Area

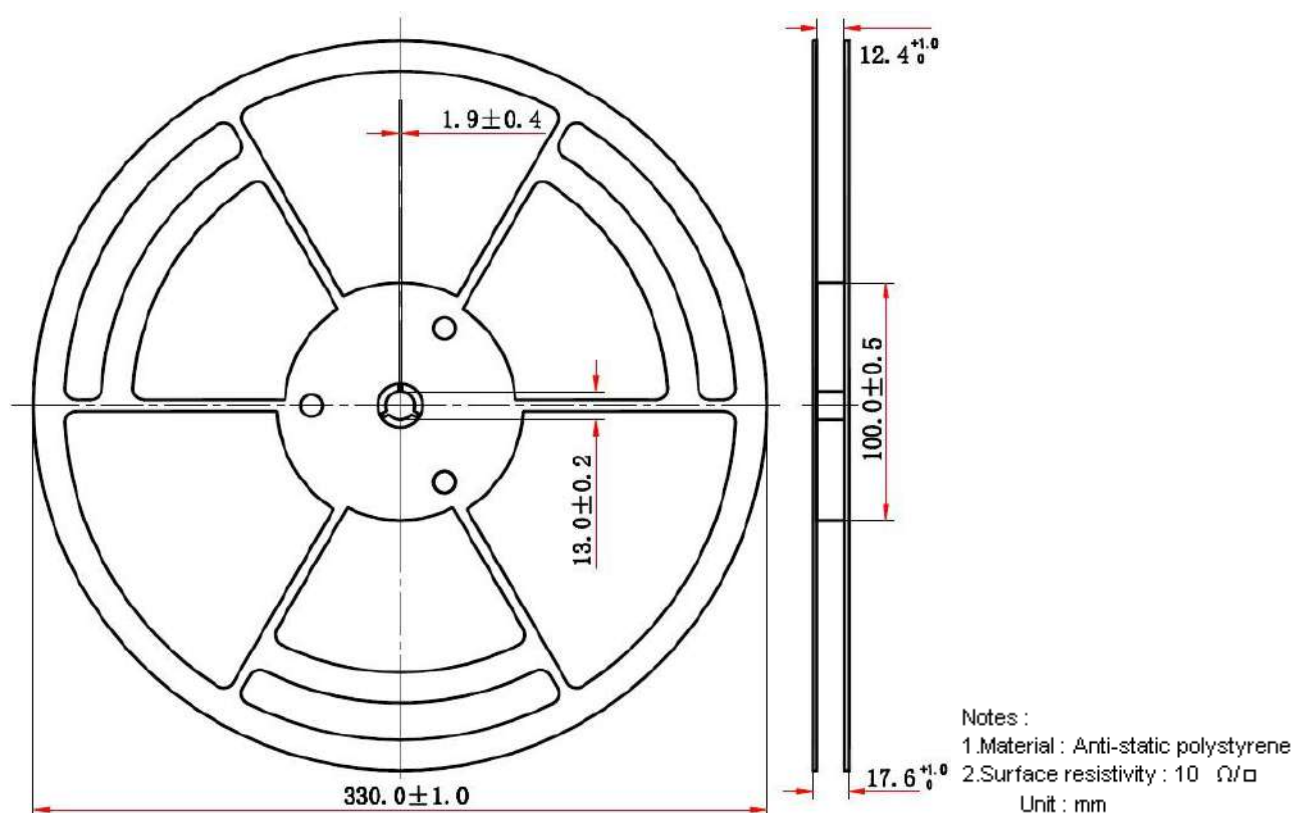


Typical Characteristics(Cont.)

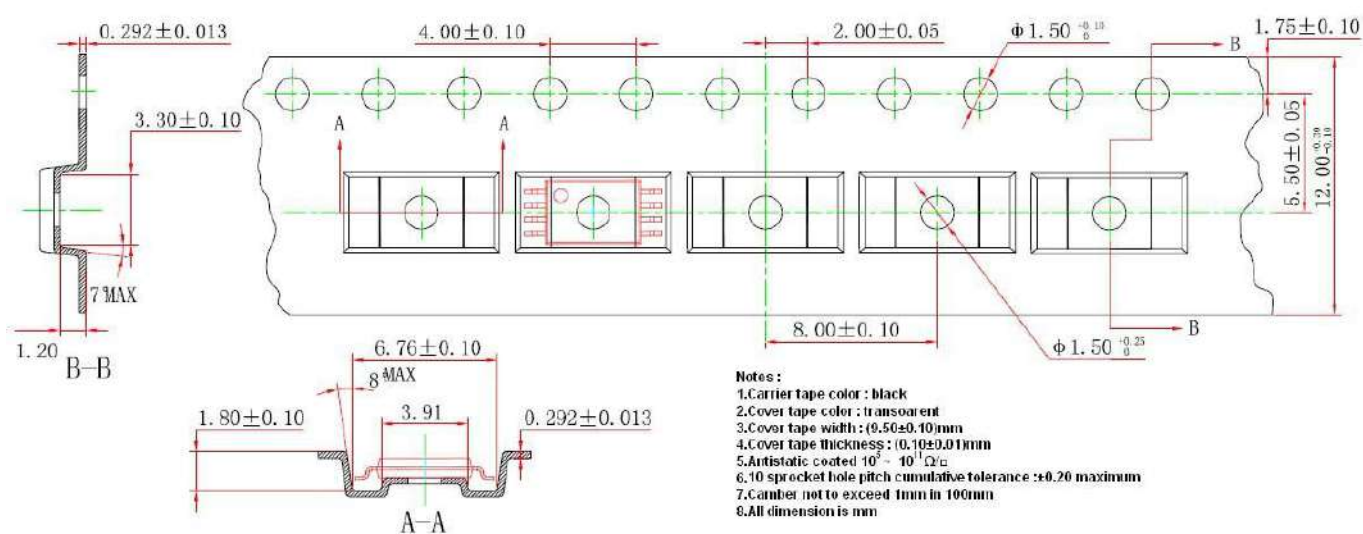
Transient Thermal Response Curves



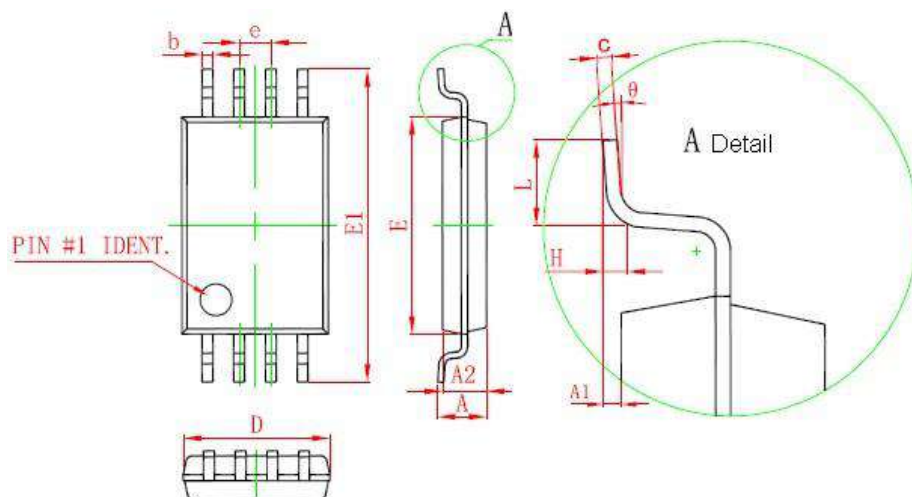
Reel Dimension



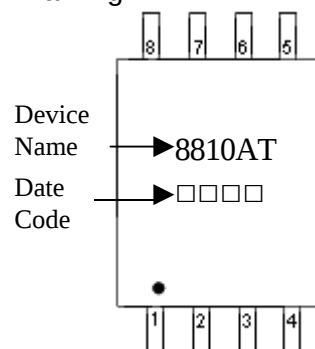
Carrier Tape Dimension



TSSOP-8 Dimension



Marking:



8-Lead TSSOP-8 Plastic Package

*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	-	1.200	-	0.047	E	4.300	4.500	0.169	0.177
A1	0.020	0.150	0.001	0.006	E1	6.250	6.550	0.246	0.258
A2	0.800	1.000	0.031	0.039	e	0.650	(BSC)	0.026	(BSC)
b	0.190	0.300	0.007	0.012	L	0.500	0.700	0.020	0.028
c	0.090	0.200	0.004	0.008	H	0.250*		0.010*	
D	2.900	3.100	0.114	0.122	θ	1°	7°	1°	7°

Notes: 1. Controlling dimension: millimeters.